

Notice of References Cited	Application/Control No. 10/565,209		Applicant(s)/Patent Under Reexamination HEIDA, BERND	
	Examiner TAM M. NGUYEN		Art Unit 1797	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0065538	04-2004	Bohner et al.	203/002
*	B	US-2003/0181772	09-2003	Meyer et al.	585/324
*	C	US-4,555,312	11-1985	Ogura et al.	203/29
*	D	US-4,504,692	03-1985	Arakawa et al.	585/633
*	E	US-4,128,457	12-1978	Barba et al.	203/29
*	F	US-3,803,258	04-1974	<i>Weitz et al.</i>	585/862 <i>203/25/24</i>
*	G	US-3,000,794	09-1961	TSCHOPP LLOYD D	203/54
*	H	US-4,859,286	08-1989	Kaibel et al.	203/75
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.